



APT40GR120B2SCD10

1200V, 40A, $V_{CE(on)}$ = 2.5V Typical

Ultra Fast NPT - IGBT®

The Ultra Fast NPT - IGBT[®] is a new generation of high voltage power IGBTs. Using Non-Punch-Through Technology, the Ultra Fast NPT-IGBT[®] offers superior ruggedness and ultrafast switching speed.

Features

- Low Saturation Voltage
- Low Tail Current
- RoHS Compliant 💋

- Short Circuit Withstand Rated
- High Frequency Switching
- Ultra Low Leakage Current

Combi (IGBT and Diode)

Unless stated otherwise, Microsemi discrete IGBTs contain a single IGBT die. This device is recommended for applications such as induction heating (IH), motor control, general purpose inverters and uninterruptible power supplies (UPS).

MAXIMUM RATINGS

All Ratings: $T_c = 25^{\circ}C$ unless otherwise specified.

Symbol	Parameter	Ratings	Unit
V _{ces}	Collector Emitter Voltage	1200	V
V_{GE}	Gate-Emitter Voltage	±30	V
I _{C1}	Continuous Collector Current @ $T_c = 25^{\circ}C$	88	
I _{C2}	Continuous Collector Current @ T _c = 110°C	40	А
I _{CM}	Pulsed Collector Current ①	160	
SCWT	Short Circuit Withstand Time: V_{ce} = 600V, V_{ge} = 15V, T_c =125°C	10	μs
P _D	Total Power Dissipation @ $T_c = 25^{\circ}C$	500	W
T_,T _{stg}	Operating and Storage Junction Temperature Range	-55 to 150	<u>.</u>
TL	Max. Lead Temp. for Soldering: 0.063" from Case for 10 Sec.	300	

STATIC ELECTRICAL CHARACTERISTICS

Symbol	Parameter	Min	Тур	Max	Unit
V _{(BR)CES}	Collector-Emitter Breakdown Voltage ($V_{GE} = 0V, I_{C} = 1.0mA$)	1200			
V _{GE(TH)}	Gate Threshold Voltage ($V_{CE} = V_{GE}$, $I_{C} = 2.0$ mA, $T_{j} = 25^{\circ}$ C)	3.5	5.0	6.5) / - I4 -
V _{CE(ON)}	Collector-Emitter On Voltage (V_{GE} = 15V, I_{C} = 40A, T_{j} = 25°C)		2.5	3.2	Volts
	Collector-Emitter On Voltage (V_{GE} = 15V, I_{C} = 40A, T_{j} = 125°C)		3.5		
	Collector-Emitter On Voltage (V_{GE} = 15V, I_{C} = 88A, T_{j} = 25°C)		3.5		
I _{ces}	Collector Cut-off Current (V _{CE} = 1200V, V _{GE} = 0V, T _j = 25°C) ⁽²⁾			1200	μA
020	Collector Cut-off Current (V_{CE} = 1200V, V_{GE} = 0V, T_j = 125°C) ⁽²⁾		300		
I _{GES}	Gate-Emitter Leakage Current (V _{GE} = ±20V)			±250	nA

CAUTION: These Devices are Sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed.



DYNAMIC CHARACTERISTICS

APT40GR120B2SCD10

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
C _{ies}	Input Capacitance	Capacitance		3980		
C _{oes}	Output Capacitance	$V_{_{\rm GE}}$ = 0V, $V_{_{\rm CE}}$ = 25V		510		pF
C _{res}	Reverse Transfer Capacitance	f = 1MHz		80		
V _{GEP}	Gate to Emitter Plateau Voltage	Cata Charge		7		V
Q _q 3	Total Gate Charge	Gate Charge		210		
Q _{ge}	Gate-Emitter Charge	$V_{gE} = 15V$		25		
Q _{gc}	Gate- Collector Charge	- V _{CE} = 600V I _C = 40A		90		nC
t _{d(on)}	Turn-On Delay Time	Inductive Switching (25°C)	1	20		
t,	Current Rise Time	V _{cc} = 600V		21		
t _{d(off)}	Turn-Off Delay Time	V _{GE} = 15V		166		ns
t _r	Current Fall Time	I _с = 40А		42	1	
E _{on} (5)	Turn-On Switching Energy	R _G = 4.3 Ω ⁽⁴⁾		929	1800	1
E _{off}	Turn-Off Switching Energy	T _J = +25°C		1070	1650	μJ
t _{d(on)}	Turn-On Delay Time	Inductive Switching (125°C)		20		
t,	Current Rise Time	V _{cc} = 600V		20		
t _{d(off)}	Turn-Off Delay Time	V _{GE} = 15V		187		ns
t _r	Current Fall Time	I _c = 40A		48		
E _{on} 5	Turn-On Switching Energy	$R_{g} = 4.3 \ \Omega^{(4)}$		971	2000	1
E _{off}	Turn-Off Switching Energy	T _J = +125°C		1042	2500	μJ

THERMAL AND MECHANICAL CHARACTERISTICS

Symbol	Characteristic	Min	Тур	Max	Unit
R _{ejc}	Junction to Case Thermal Resistance (IGBT)			.25	°C/W
	Junction to Case Thermal Resistance (Diode)			1.00	
R _{eja}	Junction to Ambient Thermal Resistance			40	
W _T	Package Weight		.22		oz
	r aunaye weiyin		6.2		g

1 Repetitive Rating: Pulse width and case temperature limited by maximum junction temperature.

2 Pulse test: Pulse Width < $380\mu s$, duty cycle < 2%.

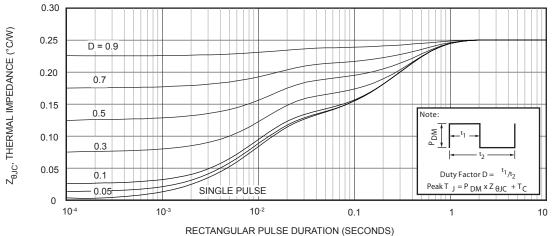
3 See Mil-Std-750 Method 3471.

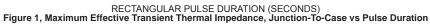
4 R_g is external gate resistance, not including internal gate resistance or gate driver impedance. (MIC4452)

5 E_{on} is the clamped inductive turn on energy that includes a commutating diode reverse transient current in the IGBT turn on energy loss. A combi device is used for the clamping diode.

6 E_{off} is the clamped inductive turn-off energy measured in accordance with JEDEC standard JESD24-1.

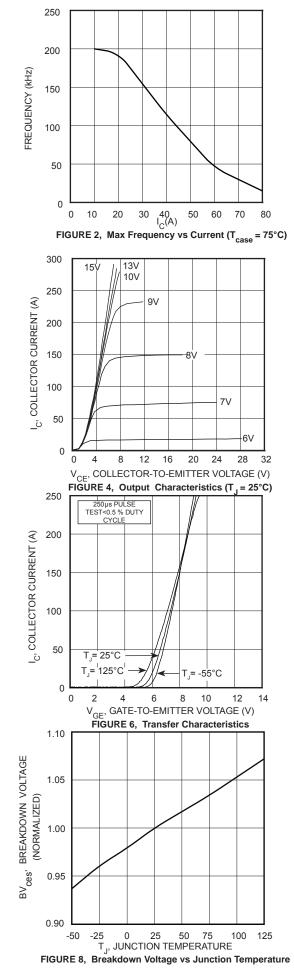
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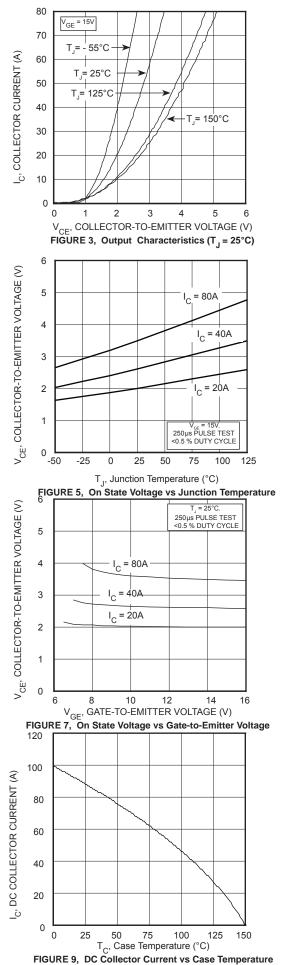


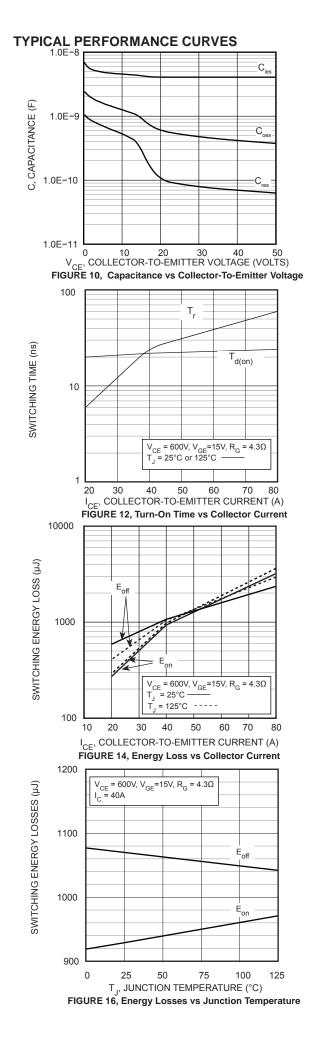


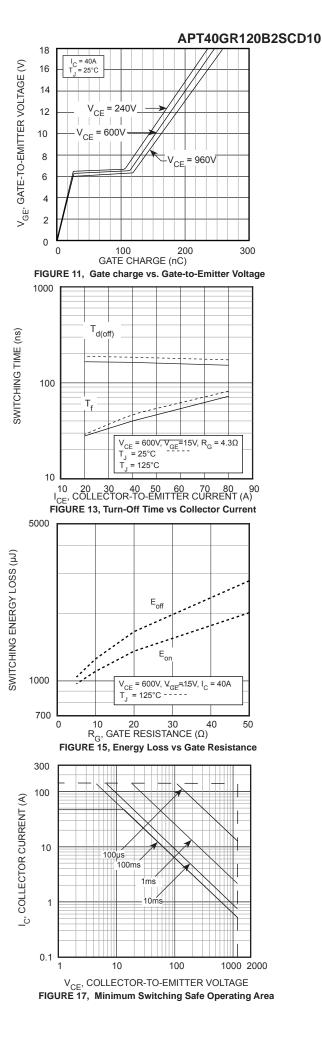
TYPICAL PERFORMANCE CURVES

APT40GR120B2SCD10









052-6406 Rev A 12-2012

ZERO RECOVERY LOW LEAKAGE SIC ANTI-PARALLEL DIODE

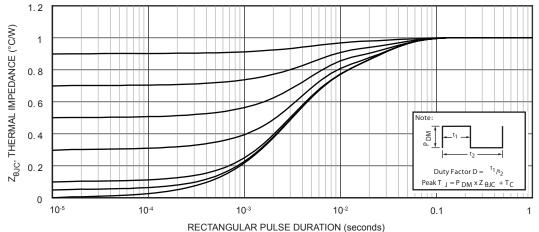
MAXIMUM RATINGS

All Ratings: $T_{C} = 25^{\circ}C$ unless otherwise specified.

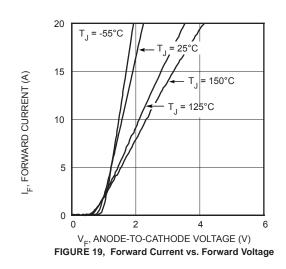
Symbol	Characteristic / Test Conditions		Ratings	Unit
	Maximum D.C. Forward Current	T _c = 25°C	36	
I _F		T _c = 135°C	10	
I _{FRM}	Repetitive Peak Forward Surge Current ($T_j = 45^{\circ}C$, $t_p = 10$ ms, Half Sine Wave)		50	Amps
I _{FSM}	Non-Repetitive Forward Surge Current (T _j = 25°C, $t_p = 1$	110		

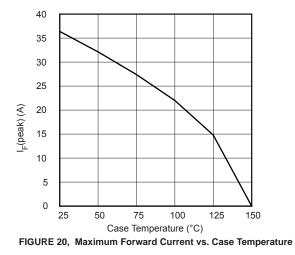
STATIC ELECTRICAL CHARACTERISTICS

Symbol	Characteristic / Test Conditions		Min	Тур	Max	Unit	
V _F	Forward Voltage	I _F = 10A T _J = 25°C		1.5		Volts	
		I _F = 10A, T _J = 150°C		2.1			
Q _c	Total Capactive Charge V _R = 800V, I _F = 10A, di/dt = -100A/ μ s, T _J = 25°C			30		nC	
	Junction Capacitance $V_{R} = 0V$, $T_{J} = 25^{\circ}C$, f = 1MHz			600			
C _T	Junction Capacitance $V_R = 200V$, $T_J = 25^{\circ}C$, f = 1MHz			71		pF	
	Junction Capacitance V_{R} = 400V, T_{J} = 25°C, f = 1MHz			52			



RECTANGULAR PULSE DURATION (seconds) FIGURE 18. MAXIMUM EFFECTIVE TRANSIENT THERMAL IMPEDANCE, JUNCTION-TO-CASE vs. PULSE DURATION



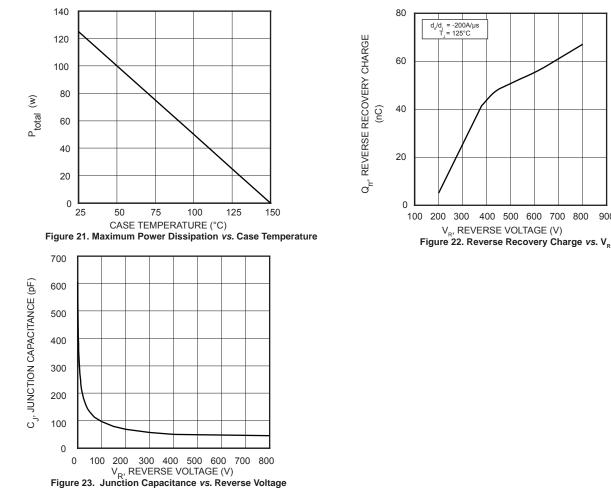


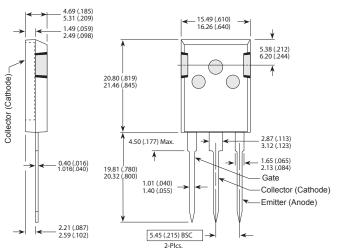
052-6406 Rev B 5-2020

TYPICAL PERFORMANCE CURVES

APT40GR120B2SCD10

900





T-MAX[®] (B2) Package Outline

These dimensions are equal to the TO-247 without the mounting hole. Dimensions in Millimeters and (Inches)

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